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What is "Embedded - Microcontrollers"?

"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "<u>Embedded - Microcontrollers</u>"

Details	
Product Status	Obsolete
Core Processor	8051
Core Size	8-Bit
Speed	67MHz
Connectivity	EBI/EMI, I <sup>2</sup> C, LINbus, SPI, UART/USART, USB
Peripherals	CapSense, DMA, POR, PWM, WDT
Number of I/O	38
Program Memory Size	32KB (32K x 8)
Program Memory Type	FLASH
EEPROM Size	1K x 8
RAM Size	4K x 8
Voltage - Supply (Vcc/Vdd)	1.71V ~ 5.5V
Data Converters	A/D 16x20b; D/A 4x8b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	68-VFQFN Exposed Pad
Supplier Device Package	68-QFN (8x8)
Purchase URL	https://www.e-xfl.com/product-detail/infineon-technologies/cy8c3865lti-032

## **PRELIMINARY**



## PSoC® 3: CY8C38 Family Datasheet

### 4.3.1 Instruction Set Summary

### 4.3.1.1 Arithmetic Instructions

Arithmetic instructions support the direct, indirect, register, immediate constant, and register-specific instructions. Arithmetic modes are used for addition, subtraction, multiplication, division, increment, and decrement operations. Table 4-1 lists the different arithmetic instructions.

Table 4-1. Arithmetic Instructions

Mnemonic	Description	Bytes	Cycles
ADD A,Rn	Add register to accumulator	1	1
ADD A,Direct	Add direct byte to accumulator	2	2
ADD A,@Ri	Add indirect RAM to accumulator	1	2
ADD A,#data	Add immediate data to accumulator	2	2
ADDC A,Rn	Add register to accumulator with carry	1	1
ADDC A,Direct	Add direct byte to accumulator with carry	2	2
ADDC A,@Ri	Add indirect RAM to accumulator with carry	1	2
ADDC A,#data	Add immediate data to accumulator with carry	2	2
SUBB A,Rn	Subtract register from accumulator with borrow	1	1
SUBB A,Direct	Subtract direct byte from accumulator with borrow	2	2
SUBB A,@Ri	Subtract indirect RAM from accumulator with borrow	1	2
SUBB A,#data	Subtract immediate data from accumulator with borrow	2	2
INC A	Increment accumulator	1	1
INC Rn	Increment register	1	2
INC Direct	Increment direct byte	2	3
INC @Ri	Increment indirect RAM	1	3
DEC A	Decrement accumulator	1	1
DEC Rn	Decrement register	1	2
DEC Direct	Decrement direct byte	2	3
DEC @Ri	Decrement indirect RAM	1	3
INC DPTR	Increment data pointer	1	1
MUL	Multiply accumulator and B	1	2
DIV	Divide accumulator by B	1	6
DAA	Decimal adjust accumulator	1	3

### 4.3.1.2 Logical Instructions

The logical instructions perform Boolean operations such as AND, OR, XOR on bytes, rotate of accumulator contents, and swap of nibbles in an accumulator. The Boolean operations on the bytes are performed on the bit-by-bit basis. Table 4-2 shows the list of logical instructions and their description.

Table 4-2. Logical Instructions

	Mnemonic Description		Bytes	Cycles
ANL	A,Rn	AND register to accumulator	1	1
ANL	A,Direct	AND direct byte to accumulator	2	2
ANL	A,@Ri	AND indirect RAM to accumulator	1	2
ANL	A,#data	AND immediate data to accumulator	2	2
ANL	Direct, A	AND accumulator to direct byte	2	3

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### 4.3.1.5 Program Branching Instructions

The 8051 supports a set of conditional and unconditional jump instructions that help to modify the program execution flow. Table 4-5 shows the list of jump instructions.

Table 4-5. Jump Instructions

Mnemonic	Description	Bytes	Cycles
ACALL addr11	Absolute subroutine call	2	4
LCALL addr16	Long subroutine call	3	4
RET	Return from subroutine	1	4
RETI	Return from interrupt	1	4
AJMP addr11	Absolute jump	2	3
LJMP addr16	Long jump	3	4
SJMP rel	Short jump (relative address)	2	3
JMP @A + DPTR	Jump indirect relative to DPTR	1	5
JZ rel	Jump if accumulator is zero	2	4
JNZ rel	Jump if accumulator is nonzero	2	4
CJNE A,Direct, rel	Compare direct byte to accumulator and jump if not equal	3	5
CJNE A, #data, rel	Compare immediate data to accumulator and jump if not equal	3	4
CJNE Rn, #data, rel	Compare immediate data to register and jump if not equal	3	4
CJNE @Ri, #data, rel	Compare immediate data to indirect RAM and jump if not equal	3	5
DJNZ Rn,rel	Decrement register and jump if not zero	2	4
DJNZ Direct, rel	Decrement direct byte and jump if not zero	3	5
NOP	No operation	1	1

### 4.4 DMA and PHUB

The PHUB and the DMA controller are responsible for data transfer between the CPU and peripherals, and also data transfers between peripherals. The PHUB and DMA also control device configuration during boot. The PHUB consists of:

- A central hub that includes the DMA controller, arbiter, and router
- Multiple spokes that radiate outward from the hub to most peripherals

There are two PHUB masters: the CPU and the DMA controller. Both masters may initiate transactions on the bus. The DMA channels can handle peripheral communication without CPU intervention. The arbiter in the central hub determines which DMA channel is the highest priority if there are multiple requests.

### 4.4.1 PHUB Features

- CPU and DMA controller are both bus masters to the PHUB
- Eight multi-layer AHB bus parallel access paths (spokes) for peripheral access
- Simultaneous CPU and DMA access to peripherals located on different spokes
- Simultaneous DMA source and destination burst transactions on different spokes
- Supports 8-, 16-, 24-, and 32-bit addressing and data

Table 4-6. PHUB Spokes and Peripherals

PHUB Spokes	Peripherals
0	SRAM
1	IOs, PICU, EMIF
2	PHUB local configuration, Power manager, Clocks, IC, SWV, EEPROM, Flash programming interface
3	Analog interface and trim, Decimator
4	USB, CAN, I <sup>2</sup> C, Timers, Counters, and PWMs
5	DFB
6	UDBs group 1
7	UDBs group 2



## 5. Memory

### 5.1 Static RAM

CY8C38 SRAM is used for temporary data storage. Up to 8 KB of SRAM is provided and can be accessed by the 8051 or the DMA controller. See Memory Map on page 19. Simultaneous access of SRAM by the 8051 and the DMA controller is possible if different 4-KB blocks are accessed.

### 5.2 Flash Program Memory

Flash memory in PSoC devices provides nonvolatile storage for user firmware, user configuration data, bulk data storage, and optional ECC data. The main flash memory area contains up to 64 KB of user program space.

Up to an additional 8 KB of flash space is available for ECC. If ECC is not used this space can store device configuration data and bulk user data. User code may not be run out of the ECC flash memory section. ECC can correct one bit error and detect two bit errors per 8 bytes of firmware memory; an interrupt can be generated when an error is detected.

Flash is read in units of rows; each row is 9 bytes wide with 8 bytes of data and 1 byte of ECC data. When a row is read, the data bytes are copied into an 8-byte instruction buffer. The CPU fetches its instructions from this buffer, for improved CPU performance.

Flash programming is performed through a special interface and preempts code execution out of flash. The flash programming interface performs flash erasing, programming and setting code protection levels. Flash in-system serial programming (ISSP), typically used for production programming, is possible through both the SWD and JTAG interfaces. In-system programming, typically used for bootloaders, is also possible using serial interfaces such as I<sup>2</sup>C, USB, UART, and SPI, or any communications protocol.

### 5.3 Flash Security

All PSoC devices include a flexible flash-protection model that prevents access and visibility to on-chip flash memory. This prevents duplication or reverse engineering of proprietary code. Flash memory is organized in blocks, where each block contains 256 bytes of program or data and 32 bytes of ECC or configuration data. A total of up to 256 blocks is provided on 64-KB flash devices.

The device offers the ability to assign one of four protection levels to each row of flash. Table 5-1 lists the protection modes available. Flash protection levels can only be changed by performing a complete flash erase. The Full Protection and Field Upgrade settings disable external access (through a debugging tool such as PSoC Creator, for example). If your application requires code update through a bootloader, then use the Field Upgrade setting. Use the Unprotected setting only when no security is needed in your application. The PSoC device also offers an advanced security feature called Device Security which permanently disables all test, programming, and debug ports, protecting your application from external access (see the "Device Security" section on page 57). For more information about how to take full advantage of the security features in PSoC, see the PSoC 3 TRM.

Table 5-1. Flash Protection

Protection Setting	Allowed	Not Allowed
Unprotected	External read and write + internal read and write	_
Factory Upgrade	External write + internal read and write	External read
Field Upgrade	Internal read and write	External read and write
Full Protection	Internal read	External read and write + internal write

#### **Disclaimer**

Note the following details of the flash code protection features on Cypress devices.

Cypress products meet the specifications contained in their particular Cypress datasheets. Cypress believes that its family of products is one of the most secure families of its kind on the market today, regardless of how they are used. There may be methods, unknown to Cypress, that can breach the code protection features. Any of these methods, to our knowledge, would be dishonest and possibly illegal. Neither Cypress nor any other semiconductor manufacturer can guarantee the security of their code. Code protection does not mean that we are guaranteeing the product as 'unbreakable'. Cypress is willing to work with the customer who is concerned about the integrity of their code. Code protection is constantly evolving. We at Cypress are committed to continuously improving the code protection features of our products.

### 5.4 EEPROM

PSoC EEPROM memory is a byte-addressable nonvolatile memory. The CY8C38 has up to 2 KB of EEPROM memory to store user data. Reads from EEPROM are random access at the byte level. Reads are done directly; writes are done by sending write commands to an EEPROM programming interface. CPU code execution can continue from flash during EEPROM writes. EEPROM is erasable and writeable at the row level. The EEPROM is divided into 128 rows of 16 bytes each. The CPU can not execute out of EEPROM. There is no ECC hardware associated with EEPROM. If ECC is required it must be handled in firmware.

### 5.5 External Memory Interface

CY8C38 provides an EMIF for connecting to external memory devices. The connection allows read and write accesses to external memories. The EMIF operates in conjunction with UDBs, I/O ports, and other hardware to generate external memory address and control signals. At 33 MHz, each memory access cycle takes four bus clock cycles. Figure 5-1 is the EMIF block diagram. The EMIF supports synchronous and asynchronous memories. The CY8C38 supports only one type of external memory device at a time. External memory can be accessed through the 8051 xdata space; up to 24 address bits can be used. See "xdata Space" section on page 21. The memory can be 8 or 16 bits wide.

External\_MEM\_ADDR[23: Address Signals Ю **PORTs** Data. Address. and Control Signals Data Signals External\_MEM\_DATA[15:0] IO IF Ю **PORTs** Control Signals Control 10 **PHUB PORTs** Data, Address. **DSI Dynamic Output** and Control Control Signals **UDB** DSI to Port Other **EM Control** Control Signals Signals Data. Address, and Control Signals **EMIF** 

Figure 5-1. EMIF Block Diagram

### 5.6 Memory Map

The CY8C38 8051 memory map is very similar to the MCS-51 memory map.

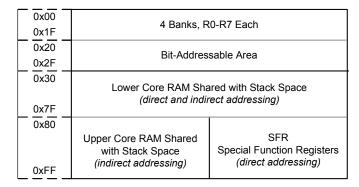
### 5.6.1 Code Space

The CY8C38 8051 code space is 64 KB. Only main flash exists in this space. See the Flash Program Memory on page 18.

### 5.6.2 Internal Data Space

The CY8C38 8051 internal data space is 384 bytes, compressed within a 256-byte space. This space consists of 256 bytes of RAM (in addition to the SRAM mentioned in Static RAM on page 18) and a 128-byte space for special function registers (SFR). See Figure 5-2. The lowest 32 bytes are used for 4 banks of registers R0-R7. The next 16 bytes are bit-addressable.

Figure 5-2. 8051 Internal Data Space





## 6.2 Power System

The power system consists of separate analog, digital, and I/O supply pins, labeled Vdda, Vddd, and Vddiox, respectively. It also includes two internal 1.8-V regulators that provide the digital (Vccd) and analog (Vcca) supplies for the internal core logic. The output pins of the regulators (Vccd and Vcca) and the Vddio pins must have capacitors connected as shown in Figure 6-4. The two Vccd pins must be shorted together, with as short a trace as possible, and connected to a 1- $\mu$ F  $\pm$ 10-percent X5R capacitor. The power system also contains a sleep regulator, an I<sup>2</sup>C regulator, and a hibernate regulator.

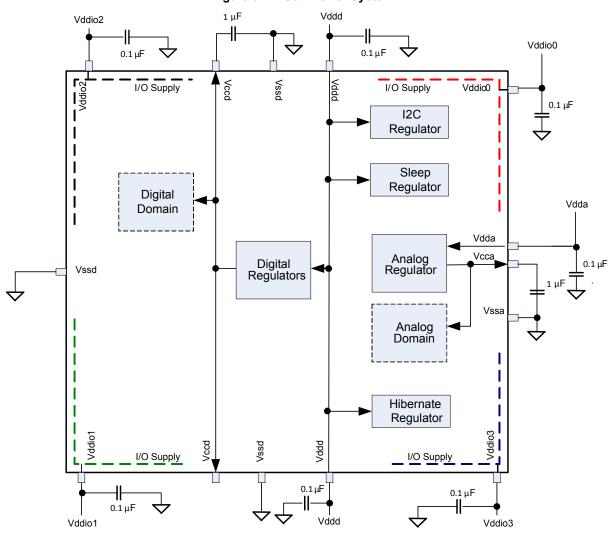


Figure 6-4. PSoC Power System

**Note** The two Vccd pins must be connected together with as short a trace as possible. A trace under the device is recommended, as shown in Figure 2-6 on page 10.



### 6.2.1 Power Modes

PSoC 3 devices have four different power modes, as shown in Table 6-2 and Table 6-3. The power modes allow a design to easily provide required functionality and processing power while simultaneously minimizing power consumption and maximizing battery life in low-power and portable devices.

PSoC 3 power modes, in order of decreasing power consumption are:

- Active
- Alternate Active
- Sleep
- Hibernate

Table 6-2. Power Modes

Active is the main processing mode. Its functionality is configurable. Each power controllable subsystem is enabled or disabled by using separate power configuration template registers. In alternate active mode, fewer subsystems are enabled, reducing power. In sleep mode most resources are disabled regardless of the template settings. Sleep mode is optimized to provide timed sleep intervals and Real Time Clock functionality. The lowest power mode is hibernate, which retains register and SRAM state, but no clocks, and allows wakeup only from I/O pins. Figure 6-5 on page 26 illustrates the allowable transitions between power modes

<b>Power Modes</b>	Description	<b>Entry Condition</b>	Wakeup Source	Active Clocks	Regulator
Active	Primary mode of operation, all peripherals available (programmable)	Wakeup, reset, manual register entry	Any interrupt	Any (programmable)	All regulators available. Digital and analog regulators can be disabled if external regulation used.
Alternate Active	Similar to Active mode, and is typically configured to have fewer peripherals active to reduce power. One possible configuration is to use the UDBs for processing, with the CPU turned off	Manual register entry	Any interrupt	Any (programmable)	All regulators available. Digital and analog regulators can be disabled if external regulation used.
Sleep	All subsystems automatically disabled	Manual register entry	Comparator, PICU, I <sup>2</sup> C, RTC, CTW, LVD	ILO/kHzECO	Both digital and analog regulators buzzed. Digital and analog regulators can be disabled if external regulation used.
Hibernate	All subsystems automatically disabled Lowest power consuming mode with all peripherals and internal regulators disabled, except hibernate regulator is enabled Configuration and memory contents retained	Manual register entry	PICU		Only hibernate regulator active.

Table 6-3. Power Modes Wakeup Time and Power Consumption

Sleep Modes	Wakeup Time	Current (typ)	Code Execution	Digital Resources	Analog Resources	Clock Sources Available	Wakeup Sources	Reset Sources
Active	-	1.2 mA <sup>[13]</sup>	Yes	All	All	All	_	All
Alternate Active	_	_	User defined	All	All	All	_	All
Sleep	<15 µs	1 μΑ	No	I <sup>2</sup> C	Comparator	ILO/kHzECO	Comparator, PICU, I <sup>2</sup> C, RTC, CTW, LVD	XRES, LVD, WDR
Hibernate	<100 µs	200 nA	No	None	None	None	PICU	XRES

### Note

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<sup>13.</sup> Bus clock off. Execute from CPU instruction buffer at 6 MHz. See Table 11-2 on page 60.



### 7.2.2 Datapath Module

The datapath contains an 8-bit single cycle ALU, with associated compare and condition generation logic. This datapath block is optimized to implement embedded functions, such as timers, counters, integrators, PWMs, PRS, CRC, shifters and dead band generators and many others.

Figure 7-8. Datapath Top Level PHUB System Bus R/W Access to All Registers F1 FIFOs Conditions: 2 Compares, 2 Zero Detect, 2 Ones Detect Overflow Detect Output Datapath Control Input FΩ Muxes Muxes Control Store RAM Input from Output to 8 Word X 16 Bit Programmable Programmable Α1 Routing Routing D1 D1 Data Registe D0 To/From To/From Previous Chaining Next Datapath Datapath Α1 Accumulator AΩ Parallel Input/Output (To/From Programmable Routing) ALU Shift Mask

## 7.2.2.1 Working Registers

The datapath contains six primary working registers, which are accessed by CPU firmware or DMA during normal operation.

Table 7-1. Working Datapath Registers

Name	Function	Description
A0 and A1	Accumulators	These are sources and sinks for the ALU and also sources for the compares.
D0 and D1	Data Registers	These are sources for the ALU and sources for the compares.
F0 and F1	FIFOs	These are the primary interface to the system bus. They can be a data source for the data registers and accumulators or they can capture data from the accumulators or ALU. Each FIFO is four bytes deep.

## 7.2.2.2 Dynamic Datapath Configuration RAM

Dynamic configuration is the ability to change the datapath function and internal configuration on a cycle-by-cycle basis, under sequencer control. This is implemented using the 8-word × 16-bit configuration RAM, which stores eight unique 16-bit wide configurations. The address input to this RAM controls the sequence, and can be routed from any block connected to the UDB routing matrix, most typically PLD logic, I/O pins, or from the outputs of this or other datapath blocks.

### **ALU**

The ALU performs eight general purpose functions. They are:

- Increment
- Decrement
- Add
- Subtract
- Logical AND
- Logical OR
- Logical XOR
- Pass, used to pass a value through the ALU to the shift register, mask, or another UDB register.



### 7.7 Timers, Counters, and PWMs

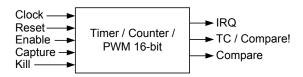
The timer/counter/PWM peripheral is a 16-bit dedicated peripheral providing three of the most common embedded peripheral features. As almost all embedded systems use some combination of timers, counters, and PWMs. Four of them have been included on this PSoC device family. Additional and more advanced functionality timers, counters, and PWMs can also be instantiated in UDBs as required. PSoC Creator allows you to choose the timer, counter, and PWM features that they require. The tool set utilizes the most optimal resources available.

The timer/counter/PWM peripheral can select from multiple clock sources, with input and output signals connected through the DSI routing. DSI routing allows input and output connections to any device pin and any internal digital signal accessible through the DSI. Each of the four instances has a compare output, terminal count output (optional complementary compare output), and programmable interrupt request line. The Timer/Counter/PWMs are configurable as free running, one shot, or Enable input controlled. The peripheral has timer reset and capture inputs, and a kill input for control of the comparator outputs. The peripheral supports full 16-bit capture.

Timer/Counter/PWM features include:

- 16-bit Timer/Counter/PWM (down count only)
- Selectable clock source
- PWM comparator (configurable for LT, LTE, EQ, GTE, GT)
- Period reload on start, reset, and terminal count
- Interrupt on terminal count, compare true, or capture
- Dynamic counter reads
- Timer capture mode
- Count while enable signal is asserted mode
- Free run mode
- One Shot mode (stop at end of period)
- Complementary PWM outputs with deadband
- PWM output kill

Figure 7-21. Timer/Counter/PWM



### 7.8 I<sup>2</sup>C

The I<sup>2</sup>C peripheral provides a synchronous two wire interface designed to interface the PSoC device with a two wire I<sup>2</sup>C serial communication bus. The bus is compliant with Philips 'The I<sup>2</sup>C Specification' version 2.1. Additional I<sup>2</sup>C interfaces can be instantiated using Universal Digital Blocks (UDBs) in PSoC Creator, as required.

To eliminate the need for excessive CPU intervention and overhead, I<sup>2</sup>C specific support is provided for status detection and generation of framing bits. I<sup>2</sup>C operates as a slave, a master, or multimaster (Slave and Master). In slave mode, the unit always listens for a start condition to begin sending or receiving data. Master mode supplies the ability to generate the Start and Stop conditions and initiate transactions. Multimaster mode provides clock synchronization and arbitration to allow multiple masters on the same bus. If Master mode is enabled and Slave mode is not enabled, the block does not generate interrupts on externally generated Start conditions. I<sup>2</sup>C interfaces through the DSI routing and allows direct connections to any GPIO or SIO pins.

I<sup>2</sup>C provides hardware address detect of a 7-bit address without CPU intervention. Additionally the device can wake from low-power modes on a 7-bit hardware address match. If wakeup functionality is required, I<sup>2</sup>C pin connections are limited to the two special sets of SIO pins.

I<sup>2</sup>C features include:

- Slave and master, transmitter, and receiver operation
- Byte processing for low CPU overhead
- Interrupt or polling CPU interface
- Support for bus speeds up to 1 Mbps (3.4 Mbps in UDBs)
- 7 or 10-bit addressing (10-bit addressing requires firmware support)
- SMBus operation (through firmware support SMBus supported in hardware in UDBs)
- 7-bit hardware address compare
- Wake from low-power modes on address match

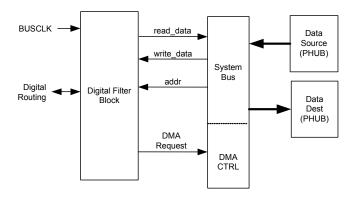
### 7.9 Digital Filter Block

Some devices in the CY8C38 family of devices have a dedicated HW accelerator block used for digital filtering. The DFB has a dedicated multiplier and accumulator that calculates a 24-bit by 24-bit multiply accumulate in one system clock cycle. This enables the mapping of a direct form FIR filter that approaches a computation rate of one FIR tap for each clock cycle. The MCU can implement any of the functions performed by this block, but at a slower rate that consumes MCU bandwidth.

The PSoC Creator interface provides a wizard to implement FIR and IIR digital filters with coefficients for LPF, BPF, HPF, Notch and arbitrary shape filters. 64 pairs of data and coefficients are stored. This enables a 64 tap FIR filter or up to 4 16 tap filters of either FIR or IIR formulation.



Figure 7-22. DFB Application Diagram (pwr/gnd not shown)



The typical use model is for data to be supplied to the DFB over the system bus from another on-chip system data source such as an ADC. The data typically passes through main memory or is directly transferred from another chip resource through DMA. The DFB processes this data and passes the result to another on chip resource such as a DAC or main memory through DMA on the system bus.

Data movement in or out of the DFB is typically controlled by the system DMA controller but can be moved directly by the MCU.

### 8. Analog Subsystem

The analog programmable system creates application specific combinations of both standard and advanced analog signal processing blocks. These blocks are then interconnected to each other and also to any pin on the device, providing a high level of design flexibility and IP security. The features of the analog subsystem are outlined here to provide an overview of capabilities and architecture.

- Flexible, configurable analog routing architecture provided by analog globals, analog mux bus, and analog local buses.
- High resolution delta-sigma ADC.
- Up to four 8-bit DACs that provide either voltage or current output.
- Four comparators with optional connection to configurable LUT outputs.
- Up to four configurable switched capacitor/continuous time (SC/CT) blocks for functions that include opamp, unity gain buffer, programmable gain amplifier, transimpedance amplifier, and mixer.
- Up to four opamps for internal use and connection to GPIO that can be used as high current output buffers.
- CapSense subsystem to enable capacitive touch sensing.
- Precision reference for generating an accurate analog voltage for internal analog blocks.

DAC DAC DelSig ADC Precision DAC Ν N Α L SC/CT Block SC/CT Block 0 ō GPIO GPIO G G Port Port g M SC/CT Block SC/CT Block R R 0 0 U U Т Comparators Ν Ν CMF CMP CMP CMP G CapSense Subsystem Config & Analog Interface **PHUB** CPU Registers DSI Clock Decimator

Figure 8-1. Analog Subsystem Block Diagram

### PRELIMINARY



## PSoC® 3: CY8C38 Family Datasheet

## 10. Development Support

The CY8C38 family has a rich set of documentation, development tools, and online resources to assist you during your development process. Visit psoc.cypress.com/getting-started to find out more.

#### 10.1 Documentation

A suite of documentation, supports the CY8C38 family to ensure that you can find answers to your questions quickly. This section contains a list of some of the key documents.

**Software User Guide**: A step-by-step guide for using PSoC Creator. The software user guide shows you how the PSoC Creator build process works in detail, how to use source control with PSoC Creator, and much more.

**Component Datasheets**: The flexibility of PSoC allows the creation of new peripherals (components) long after the device has gone into production. Component datasheets provide all of the information needed to select and use a particular component, including a functional description, API documentation, example code, and AC/DC specifications.

**Application Notes:** PSoC application notes discuss a particular application of PSoC in depth; examples include brushless DC motor control and on-chip filtering. Application notes often include example projects in addition to the application note document.

**Technical Reference Manual**: The Technical Reference Manual (TRM) contains all the technical detail you need to use a PSoC device, including a complete description of all PSoC registers.

### 10.2 Online

In addition to print documentation, the Cypress PSoC forums connect you with fellow PSoC users and experts in PSoC from around the world, 24 hours a day, 7 days a week.

### 10.3 Tools

With industry standard cores, programming, and debugging interfaces, the CY8C38 family is part of a development tool ecosystem. Visit us at <a href="https://www.cypress.com/go/psoccreator">www.cypress.com/go/psoccreator</a> for the latest information on the revolutionary, easy to use PSoC Creator IDE, supported third party compilers, programmers, debuggers, and development kits.



Table 11-28. Comparator AC Specifications

Parameter	Description	Conditions	Min	Тур	Max	Units
	Response time, high current mode <sup>[39]</sup>	50 mV overdrive, measured pin-to-pin	_	75	110	ns
T <sub>RESP</sub>	Response time, low current mode <sup>[39]</sup>	50 mV overdrive, measured pin-to-pin	-	155	200	ns
	Response time, ultra low-power mode <sup>[39]</sup>	50 mV overdrive, measured pin-to-pin	_	55	_	μs

### 11.5.6 Current Digital-to-analog Converter(IDAC)

See the IDAC component datasheet in PSoC Creator for full electrical specifications and APIs.

Unless otherwise specified, all charts and graphs show typical values.

Table 11-29. IDAC DC Specifications

Parameter	Description	Conditions	Min	Тур	Max	Units
	Resolution		_	_	8	bits
Гоит	Output current at code = 255	Range = 2.048 mA, code = 255, $V_{DDA} \ge 2.7$ V, Rload = 600 $\Omega$	-	2.048	ı	mA
		Range = 2.048 mA, High mode, code = 255, $V_{DDA} \le 2.7$ V, Rload = 300 $\Omega$	-	2.048	-	mA
		Range = 255 $\mu$ A, code = 255, Rload = 600 $\Omega$	_	255	_	μА
		Range = 31.875 $\mu$ A, code = 255, Rload = 600 $\Omega$	_	31.875	_	μА
	Monotonicity		_	_	Yes	
Ezs	Zero scale error		_	0	±1	LSB
Eg	Gain error	Range = 2.048 mA, 25 °C	_	_	±2.5	%
		Range = 255 μA, 25 ° C	_	_	±2.5	%
		Range = 31.875 μA, 25 ° C	_	_	±3.5	%
TC_Eg	Temperature coefficient of gain error	Range = 2.048 mA	-	-	0.04	% / °C
		Range = 255 μA	_	_	0.04	% / °C
		Range = 31.875 μA	_	_	0.05	% / °C
INL	Integral nonlinearity	Sink mode, range = $255 \mu\text{A}$ , Codes 8 – $255$ , Rload = $2.4 k\Omega$ , Cload = $15 p\text{F}$	-	±0.9	±1	LSB
		Source mode, range = 255 $\mu$ A, Codes 8 – 255, Rload = 2.4 $k\Omega$ , Cload = 15 pF	-	±1.2	±1.5	LSB
DNL	Differential nonlinearity	Sink mode, range = 255 μA, Rload = 2.4 kΩ, Cload = 15 pF	_	±0.3	±1	LSB
		Source mode, range = 255 $\mu$ A, Rload = 2.4 $k\Omega$ , Cload = 15 pF	_	±0.3	±1	LSB
Vcompliance	Dropout voltage, source or sink mode	Voltage headroom at max current, Rload to Vdda or Rload to Vssa, Vdiff from Vdda	1	_	-	V

#### Note

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<sup>39.</sup> Based on device characterization (Not production tested).



Figure 11-33. IDAC Operating Current vs Temperature, Range = 255  $\mu$ A, Code = 0, Source Mode

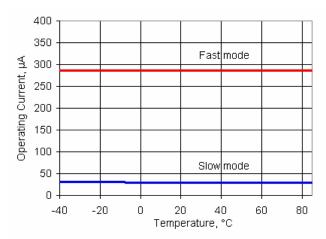


Figure 11-34. IDAC Operating Current vs Temperature, Range = 255 µA, Code = 0, Sink Mode

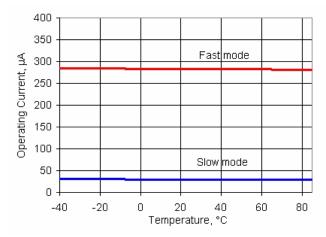


Table 11-30. IDAC AC Specifications

Parameter	Description	Conditions	Min	Тур	Max	Units
F <sub>DAC</sub>	Update rate		_	_	8	Msps
T <sub>SETTLE</sub>	Settling time to 0.5 LSB	Range = 31.875 $\mu$ A or 255 $\mu$ A, full scale transition, fast mode, 600 $\Omega$ 15-pF load	-	_	125	ns



### 11.5.8 Mixer

The mixer is created using a SC/CT analog block; see the Mixer component datasheet in PSoC Creator for full electrical specifications and APIs.

Table 11-33. Mixer DC Specifications

Parameter	Description	Conditions	Min	Тур	Max	Units
V <sub>OS</sub>	Input offset voltage		_	_	10	mV
	Quiescent current		_	0.9	2	mA
G	Gain		_	0	_	dB

### Table 11-34. Mixer AC Specifications

Parameter	Description	Conditions	Min	Тур	Max	Units
$f_{LO}$	Local oscillator frequency	Down mixer mode	_	_	4	MHz
f <sub>in</sub>	Input signal frequency	Down mixer mode	_	_	14	MHz
$f_{LO}$	Local oscillator frequency	Up mixer mode	_	_	1	MHz
f <sub>in</sub>	Input signal frequency	Up mixer mode	_	_	1	MHz
SR	Slew rate		3	_	_	V/µs

### 11.5.9 Transimpedance Amplifier

The TIA is created using a SC/CT analog block; see the TIA component datasheet in PSoC Creator for full electrical specifications and APIs.

Table 11-35. Transimpedance Amplifier (TIA) DC Specifications

Parameter	Description	Conditions	Min	Тур	Max	Units
V <sub>IOFF</sub>	Input offset voltage		_	-	10	mV
Rconv	Conversion resistance <sup>[40]</sup>	R = 20K; 40 pF load	-25	-	+35	%
		R = 30K; 40 pF load	-25	_	+35	%
		R = 40K; 40 pF load	-25	_	+35	%
		R = 80K; 40 pF load	-25	_	+35	%
		R = 120K; 40 pF load	-25	_	+35	%
		R = 250K; 40 pF load	-25	_	+35	%
		R= 500K; 40 pF load	-25	_	+35	%
		R = 1M; 40 pF load	-25	-	+35	%
	Quiescent current		_	1.1	2	mA

## Table 11-36. Transimpedance Amplifier (TIA) AC Specifications

Parameter	Description	Conditions	Min	Тур	Max	Units
BW	Input bandwidth (-3 dB)	R = 20K; –40 pF load	1500	_	_	kHz
		R = 120K; –40 pF load	240	_	_	kHz
		R = 1M; –40 pF load	25	_	_	kHz

#### Note

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<sup>40.</sup> Conversion resistance values are not calibrated. Calibrated values and details about calibration are provided in PSoC Creator component datasheets. External precision resistors can also be used.



Table 11-38. PGA AC Specifications

Parameter	Description	Conditions	Min	Тур	Max	Units
BW1	-3 dB bandwidth	Power mode = high, gain = 1, input = 100 mV peak-to-peak	6.7	8	-	MHz
SR1	Slew rate	Power mode = high, gain = 1, 20% to 80%	3	_	-	V/µs
e <sub>n</sub>	Input noise density	Power mode = high, Vdda = 5 V, at 100 kHz	-	43	ı	nV/sqrtHz

Figure 11-44. Gain vs. Frequency, at Different Gain Settings, Vdda = 3.3 V, Power Mode = High

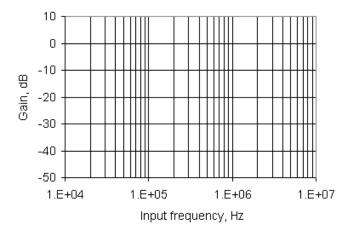
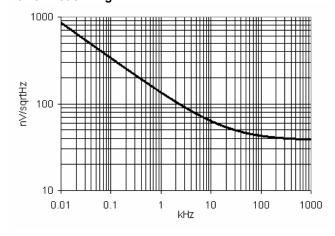


Figure 11-46. Noise vs. Frequency, Vdda = 5 V, Power Mode = High

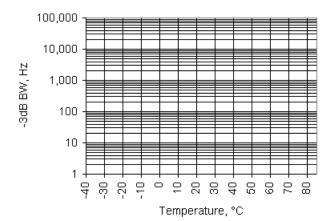


## 11.5.11 Temperature Sensor

Table 11-39. Temperature Sensor Specifications

Parameter	Description	Conditions	Min	Тур	Max	Units
	Temp sensor accuracy	Range: -40 °C to +85 °C	1	±5	_	°C

Figure 11-45. Bandwidth vs. Temperature, at Different Gain Settings, Power Mode = High



## **PRELIMINARY**



# PSoC® 3: CY8C38 Family Datasheet

## 11.6.6 Digital Filter Block

## Table 11-51. DFB DC Specifications

Parameter	Description	Conditions	Min	Тур	Max	Units
	DFB operating current	64-tap FIR at F <sub>DFB</sub>				
		100 kHz (1.3 ksps)	_	0.03	0.05	mA
		500 kHz (6.7 ksps)	-	0.16	0.27	mA
		1 MHz (13.4 ksps)	_	0.33	0.53	mA
		10 MHz (134 ksps)	-	3.3	5.3	mA
		48 MHz (644 ksps)	-	15.7	25.5	mA
		67 MHz (900 ksps)	_	21.8	35.6	mA

## Table 11-52. DFB AC Specifications

Parameter	Description	Conditions	Min	Тур	Max	Units
F <sub>DFB</sub>	DFB operating frequency		DC	_	67	MHz

### 11.6.7 USB

## Table 11-53. USB DC Specifications

Parameter	Description	Conditions	Min	Тур	Max	Units
V <sub>USB_5</sub>	Device supply for USB operation	USB configured, USB regulator enabled	4.35	_	5.25	V
V <sub>USB_3.3</sub>		USB configured, USB regulator bypassed	3.15	-	3.6	V
V <sub>USB_3</sub>		USB configured, USB regulator bypassed <sup>[42]</sup>	2.85	_	3.6	V

Note
42. Rise/fall time matching (TR) not guaranteed, see USB Driver AC Specifications on page 68.



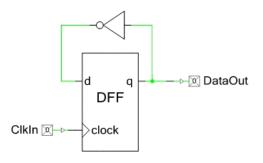
## 11.6.8 Universal Digital Blocks (UDBs)

PSoC Creator provides a library of prebuilt and tested standard digital peripherals (UART, SPI, LIN, PRS, CRC, timer, counter, PWM, AND, OR, and so on) that are mapped to the UDB array. See the component datasheets in PSoC Creator for full AC/DC specifications, APIs, and example code.

Table 11-54. UDB AC Specifications

Parameter	Description	Conditions	Min	Тур	Max	Units
Datapath Per	formance		•			•
F <sub>MAX_TIMER</sub>	Maximum frequency of 16-bit timer in a UDB pair		_	_	67	MHz
F <sub>MAX_ADDER</sub>	Maximum frequency of 16-bit adder in a UDB pair		_	-	67	MHz
F <sub>MAX_CRC</sub>	Maximum frequency of 16-bit CRC/PRS in a UDB pair		_	-	67	MHz
PLD Perform	ance					
F <sub>MAX_PLD</sub>	Maximum frequency of a two-pass PLD function in a UDB pair		_	_	67	MHz
Clock to Outp	out Performance		•	•		•
t <sub>CLK_OUT</sub>	Propagation delay for clock in to data out, see Figure 11-47.	25 °C, Vddd $\geq$ 2.7 V	_	20	25	ns
t <sub>CLK_OUT</sub>	Propagation delay for clock in to data out, see Figure 11-47.	Worst-case placement, routing, and pin selection	_	_	55	ns

Figure 11-47. Clock to Output Performance





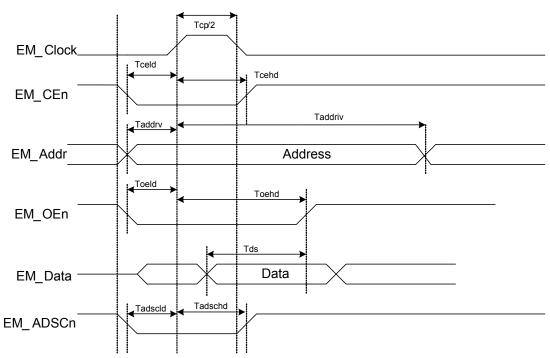


Figure 11-50. Synchronous Read Cycle Timing

Table 11-65. Synchronous Read Cycle Specifications

Parameter	Description	Conditions	Min	Тур	Max	Units
Т	EMIF clock period <sup>[44]</sup>	Vdda ≥ 3.3 V	30.3	-	_	nS
Tcp/2	EM_Clock pulse high		T/2	_	_	nS
Tceld	EM_CEn low to EM_Clock high		5	_	_	nS
Tcehd	EM_Clock high to EM_CEn high		T/2 – 5	_	_	nS
Taddrv	EM_Addr valid to EM_Clock high		5	_	1	nS
Taddriv	EM_Clock high to EM_Addr invalid		T/2 – 5	_	1	nS
Toeld	EM_OEn low to EM_Clock high		5	_	_	nS
Toehd	EM_Clock high to EM_OEn high		Т	_	_	nS
Tds	Data valid before EM_OEn high		T + 15	_	_	nS
Tadscld	EM_ADSCn low to EM_Clock high		5	_	_	nS
Tadschd	EM_Clock high to EM_ADSCn high		T/2 – 5	_	_	nS

#### Note

44. Limited by GPIO output frequency, see Table 11-10 on page 65.

Tcp/2 EM\_Clock Tceld Tcehd EM\_CEn Taddriv Taddrv EM\_Addr Address Tweld Twehd EM\_WEn Tdh EM\_Data Data Tadschd Tadscld EM\_ADSCn

Figure 11-51. Synchronous Write Cycle Timing

Table 11-66. Synchronous Write Cycle Specifications

Parameter	Description	Conditions	Min	Тур	Max	Units
Т	EMIF clock Period <sup>[45]</sup>	Vdda ≥ 3.3 V	30.3	_	_	nS
Tcp/2	EM_Clock pulse high		T/2	_	_	nS
Tceld	EM_CEn low to EM_Clock high		5	_	_	nS
Tcehd	EM_Clock high to EM_CEn high		T/2 - 5	_	_	nS
Taddrv	EM_Addr valid to EM_Clock high		5	_	_	nS
Taddriv	EM_Clock high to EM_Addr invalid		T/2 - 5	_	_	nS
Tweld	EM_WEn low to EM_Clock high		5	_	_	nS
Twehd	EM_Clock high to EM_WEn high		T/2 - 5	_	_	nS
Tds	Data valid before EM_Clock high		5	_	_	nS
Tdh	Data invalid after EM_Clock high		Т	_	_	nS
Tadscld	EM_ADSCn low to EM_Clock high		5	_	_	nS
Tadschd	EM_Clock high to EM_ADSCn high		T/2 - 5	_	_	nS

#### Note

<sup>45.</sup> Limited by GPIO output frequency, see Table 11-10 on page 65.



## 11.8.3 Interrupt Controller

## Table 11-71. Interrupt Controller AC Specifications

Parameter	Description	Conditions	Min	Тур	Max	Units
	Delay from interrupt signal input to ISR code execution from ISR code	Includes worse case completion of longest instruction DIV with 6 cycles	-	1	25	Tcy CPU

### 11.8.4 JTAG Interface

## Table 11-72. JTAG Interface AC Specifications<sup>[46]</sup>

Parameter	Description	Conditions	Min	Тур	Max	Units
f_TCK	TCK frequency	$3.3 \text{ V} \leq \text{V}_{DDD} \leq 5 \text{ V}$	_	_	14 <sup>[47]</sup>	MHz
		1.71 V ≤ V <sub>DDD</sub> < 3.3 V	_	_	7 <sup>[47]</sup>	MHz
T_TDI_setup	TDI setup before TCK high		(T/10) - 5	-	-	ns
T_TMS_setup	TMS setup before TCK high		T/4	-	-	
T_TDI_hold	TDI, TMS hold after TCK high	T = 1/f_TCK	T/4	_	_	
T_TDO_valid	TCK low to TDO valid	T = 1/f_TCK	2T/5	-	_	
T_TDO_hold	TDO hold after TCK high	T = 1/f_TCK	T/4	-	-	
	TCK to device outputs valid		_	-	2T/5	

### 11.8.5 SWD Interface

## Table 11-73. SWD Interface AC Specifications<sup>[46]</sup>

Parameter	Description	Conditions	Min	Тур	Max	Units
f_SWDCK	SWDCLK frequency	$3.3 \text{ V} \leq \text{V}_{DDD} \leq 5 \text{ V}$	_	_	14 <sup>[48]</sup>	MHz
		1.71 V ≤ V <sub>DDD</sub> < 3.3 V	-	_	7 <sup>[48]</sup>	MHz
		$1.71 \text{ V} \le \text{V}_{DDD} < 3.3 \text{ V},$ SWD over USBIO pins	_	_	5.5 <sup>[48]</sup>	MHz
T_SWDI_setup	SWDIO input setup before SWDCK high	T = 1/f_SWDCK	T/4	_	_	
T_SWDI_hold	SWDIO input hold after SWDCK high	T = 1/f_SWDCK	T/4	_	_	
T_SWDO_valid	SWDCK low to SWDIO output valid	T = 1/f_SWDCK	2T/5	_	_	
T_SWDO_hold	SWDIO output hold after SWDCK high	T = 1/f_SWDCK	T/4	_	_	

### 11.8.6 SWV Interface

## Table 11-74. SWV Interface AC Specifications<sup>[46]</sup>

Parameter	Description	Conditions	Min	Тур	Max	Units
	SWV mode SWV bit rate		-	-	33	Mbit

#### Notes

46. Based on device characterization (Not production tested).

47. f\_TCK must also be no more than 1/3 CPU clock frequency.
48. f\_SWDCK must also be no more than 1/3 CPU clock frequency.

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## 14. Acronyms

Table 14-1. Acronyms Used in this Document

Acronym	Description
abus	analog local bus
ADC	analog-to-digital converter
AG	analog global
АНВ	AMBA (advanced microcontroller bus architecture) high-performance bus, an ARM data transfer bus
ALU	arithmetic logic unit
AMUXBUS	analog multiplexer bus
API	application programming interface
APSR	application program status register
ARM <sup>®</sup>	advanced RISC machine, a CPU architecture
ATM	automatic thump mode
BW	bandwidth
CAN	Controller Area Network, a communications protocol
CMRR	common-mode rejection ratio
CPU	central processing unit
CRC	cyclic redundancy check, an error-checking protocol
DAC	digital-to-analog converter, see also IDAC, VDAC
DFB	digital filter block
DIO	digital input/output, GPIO with only digital capabilities, no analog. See GPIO.
DMA	direct memory access, see also TD
DNL	differential nonlinearity, see also INL
DNU	do not use
DR	port write data registers
DRES	digital logic reset
DSI	digital system interconnect
DWT	data watchpoint and trace
ECC	error correcting code
ECO	external crystal oscillator
EEPROM	electrically erasable programmable read-only memory
EMI	electromagnetic interference
EMIF	external memory interface
EOC	end of conversion
EOF	end of frame
EPSR	execution program status register
ESD	electrostatic discharge

Table 14-1. Acronyms Used in this Document (continued)

Acronym	Description
ETM	embedded trace macrocell
FIR	finite impulse response, see also IIR
FPB	flash patch and breakpoint
FS	full-speed
GPIO	general-purpose input/output, applies to a PSoC pin
HVI	high-voltage interrupt, see also LVI, LVD
IC	integrated circuit
IDAC	current DAC, see also DAC, VDAC
IDE	integrated development environment
I <sup>2</sup> C, or IIC	Inter-Integrated Circuit, a communications protocol
IIR	infinite impulse response, see also FIR
ILO	internal low-speed oscillator, see also IMO
IMO	internal main oscillator, see also ILO
INL	integral nonlinearity, see also DNL
I/O	input/output, see also GPIO, DIO, SIO, USBIO
IPOR	initial power-on reset
IPSR	interrupt program status register
IRQ	interrupt request
ITM	instrumentation trace macrocell
LCD	liquid crystal display
LIN	Local Interconnect Network, a communications protocol.
LR	link register
LUT	lookup table
LVD	low-voltage detect, see also LVI
LVI	low-voltage interrupt, see also HVI
LVTTL	low-voltage transistor-transistor logic
MAC	multiply-accumulate
MCU	microcontroller unit
MISO	master-in slave-out
NC	no connect
NMI	nonmaskable interrupt
NRZ	non-return-to-zero
NVIC	nested vectored interrupt controller
NVL	nonvolatile latch, see also WOL
opamp	operational amplifier
PAL	programmable array logic, see also PLD
PC	program counter
PCB	printed circuit board

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